# MORNSUN

## QC962 Hybrid Integrated IGBT Driver

QC962 is a hybrid integrated IGBT driver designed for driving N-channel IGBT modules in any gate amplifier application. The device provides the required electrical isolation between input and output with the opto-coupler. Short circuit protection is provided by a built-in desaturation detector. A fault signal is provided if the short circuit protection is activate.



### FEATURES

- Built in high CMRR opto-coupler (CMR:Typical: 30kV/µs, Min.:15kV/µs)
- Two supply drive topology
- TTL compatible input interface
- Electrical isolation voltage between input and output with opto-couplers (Viso=3750VRMS/min)
- Built in short circuit protection circuit with a pin for fault output
- Soft IGBT turn-off and protection circuit time reset
- Controlled time detected short circuit
- Switching frequency up to 20kHz
- Pin and characteristic are compatible with M57962AL

## APPLICATION

- General-purpose Inverter
- AC Servo Systems
- Uninterruptable Power Supplies(UPS)
- Welding Machines

## RECOMMENDED MODULES

- 600V Series IGBT(up to 600A)
- 1200V Series IGBT(up to 400A)
- 1700V Series IGBT(up to 200A)

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Item		Test Conditions	Limit	Units
Supply Voltage*	Vcc	DC	18	V
Supply Voltage*	$V_{\text{EE}}$	be	-15	V
Input Voltage	Vi	Between pin13 and pin14	-1~+7	V
Output Voltage	Vo	Output voltage "H"	V <sub>cc</sub>	V
Output Current	I <sub>g on</sub>	Pulse width 2µs	+5	A
	I <sub>g off</sub>	Frequency f=20kHz	-5	A
Isolation Voltage	V <sub>iso</sub>	Sine wave voltage 50Hz / 60Hz,1 min.	3750	V
Junction Temperature	TJ		150	°C
Operation Temperature	T <sub>op</sub>		-20~+70	°C
Storage Temperature	T <sub>st</sub>		-40~+125	°C
Fault Output Current	I <sub>FO</sub>		20	mA
Input Voltage	V <sub>R1</sub>	Pin 1 voltage	50	V

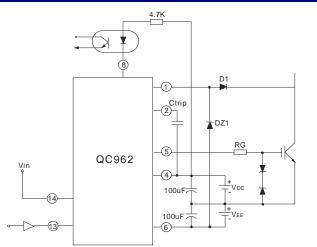
2. \*20V<V<sub>CC</sub>-V<sub>EE</sub><28V.

## **ELECTRICAL CHARACTERISTIC**

Characteristics	т	Test Conditions	Value			Units
Charactenstics			Min	Тур.	Max	Units
Supply Voltage	V <sub>cc</sub>	Recommended Range	14	15	-	V
	V <sub>EE</sub>		-7	-	-10	V
Pull-up voltage on input side	V <sub>IN</sub>	Recommended Range	4.75	5	5.25	V
"H" input current	I <sub>IH</sub>	Recommended Range	15.2	16	19	mA
Switching frequency	f	Recommended Range			20	kHz
Gate resistant	R <sub>G</sub>	Recommended Range	2			Ω
"H" input current	I <sub>IH</sub>	V <sub>IN</sub> =5V	-	16	-	mA
"H" output voltage	V <sub>он</sub>		13	14	-	V
"L" output voltage	V <sub>OL</sub>		-6	-	-9	V
"L-H" propagation	t <sub>PLH</sub>	I <sub>IH</sub> =16mA	-	0.5	1	μs
"L-H" rise time	tr	I <sub>IH</sub> =16mA		0.6	1	μs
"H-L" propagation	t <sub>PHL</sub>	I <sub>IH</sub> =16mA		1	1.3	μs
"H-L" fall time	t <sub>f</sub>	I <sub>IH</sub> =16mA		0.4	1	μs
Protection threshold voltage	V <sub>OCP</sub>	Vcc=15V,V <sub>EE</sub> =-10V		8.4		V
Protection reset time	t <sub>timer</sub>		1	1.3	2	ms
Fault output current	I <sub>FO</sub>	Pin8 input current, R=4.7K		5		mA
Controlled time detect short circuit 1	T <sub>trip1</sub>	Pin1: ≥15V,Pin2:open		2.6		μs
Controlled time detect short circuit 2	T <sub>trip2</sub>	Pin1:≥15V Pin2- Pin4:1000pF		3		μs
Soft turn-off time	T <sub>off2</sub>	PIN1:≥15V,PIN2:open		5		μs
SC detect voltage	V <sub>SC</sub>	Collector voltage of module	15			V
Notes: 1. Ta=25°C, V <sub>CC</sub> =15V, V <sub>E</sub>	<sub>E</sub> =-10V.	unless otherwise specified				

T. Ta=25 C, V<sub>CC</sub>=15V, V<sub>EE</sub>=-10V. unless otherwise spect
2. "H"represents high level; "L" represents low level.

## **APPLICATION EXAMPLES**



f=20kHz

V<sub>CC</sub>=15V

 $V_{EE}=10V$ 

Ctrip=0~3300pF

TTL compatible input interface

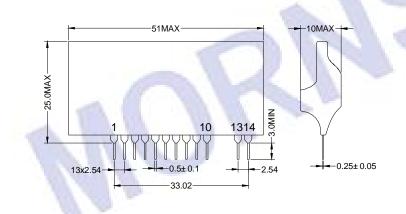
Duty:50%

V<sub>IN</sub>=5V

R<sub>G</sub>=3.1Ω

D<sub>1</sub> :Fast Recovery Diode(trr≤0.2µs)

## **OUTLINE DRAWING**



#### **PIN FUNCTION:**

Pin number	Description
1	Fault detect
2	Reaction time
4	Power supply(+)
5	Drive output
6	Power supply(-)
8	Fault signal output
13	Drive signal input(-)
14	Drive signal input(+)
3, 7, 9, 10	Not connected

## APPLICATION NOTES

- 1. The IGBT gate-emitter drive loop wiring must be shorter than one meter.
- The IGBT gate-emitter drive loop wiring should be twisted.
- 3. If large voltage spike is generated at the collector of the IGBT, increase the IGBT gate resistor.
- 4. Pin3,7,9,10 are used only for the test circuit and not be connected with the application circuit.
- 5. The external blocking capacitors must be connected as close as possible to the driver's pin.
- Peak reverse voltage of the diode D1 must be higher than the peak value of the IGBT collector voltage.
- 7. The distance between the capacitor Ctrip and pin2-4 should be as short as possible(Max.5cm)
- Pin1 voltage could be high due to the reverse recovery characteristic of the diode D<sub>1</sub> and the 30V zener diode DZ1 is connected between pin1 and pin6 for protecting the driver.